Remarks

Claims 1–15 are pending in this application. Claims 1 and 9 are independent; Claims 2–8 depend from Claim 1, and Claims 10–15 depend from Claim 9. The remarks below and the accompanying Declaration of Prior Invention necessitate neither further search nor extensive consideration by the Examiner, and are believed to place the application in condition for allowance. Therefore, their consideration is respectfully requested.

Claim Rejections Under 35 U.S.C. § 102(e) and 35 U.S.C. § 103.

Claims 1–3, 9–11 and 15 stand rejected under 35 U.S.C. § 102(e) as being anticipated by U.S. Patent 6,800,830 ("Mahawili"). Claims 4–8 and 12–14 stand rejected as being obvious based on Mahawili in view of one or more of U.S. Patent 6,727,148 ("Setton"), U.S. Patent 6,297,539 ("Ma") and U.S. Patent 6,744,104 ("Aoki"). Claims 1 and 9 are the only independent claims pending in this application.

Applicants respectfully traverse these rejections on the grounds that Mahawili is not available as prior art against these claims because Applicants invented the claimed subject matter before the effective date of Mahawili.

As expounded in the Declaration of Prior Invention which accompanies this Response, the inventors conceived of the invention disclosed and claimed in the present application before 18 August 2000, which is the earliest priority date to which Mahawili may be entitled. The attached Declaration further states that the inventors worked with due diligence from before the filing date of Mahawili to the constructive reduction to practice of their invention on 24 November 2000 with the filing of U.S. Provisional Patent Application 60/253,693, to which the present application claims priority. Consequently, Mahawili does not qualify as prior art against the present claims and Applicants respectfully request the withdrawal of all rejections based wholly or partially on Mahawili.

Application Number 10/626,217 Amendment dated 21 January 2005 Reply to Office Action of 17 December 2004

Conclusion.

In view of the foregoing, Applicants submit that this application is in condition for allowance, and respectfully request the same. If, however, some issue remains that the Examiner feels can be addressed by an Examiner's Amendment, the Examiner is cordially invited to call the undersigned for authorization.

Respectfully submitted,

KNOBBE MARTENS OLSON & BEAR LLP

Dated: 21 jan 05

By: ____

Kyle Schlueter
Registration No. 54,912

Attorney of Record Customer No. 20,995

(310) 551-3450

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Number: 10/626,217

Confirmation Number: 9650

Applicant:

Pomarede, et al.

Filing Date:

24 July 2003

Art Unit:

2822

Examiner:

Christy L. Novacek

Customer Number:

20,995

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Commissioner for Patents Post Office Box 1450 Alexandria, Virginia 22313-1450

DUPLICATE COPY OF EARLIER SUBMISSION

Sir:

An after-final submission was filed via facsimile in the above-captioned application on 21 January 2005. The submission included a Transmittal Letter with Certificate of Fax Transmission in 1 page, an IDS with PTO/SB/08 in 2 pages, a Response to Final Office Action in 3 pages and an Declaration under 37 C.F.R. § 1.131 with Exhibit in 9 pages. Of these papers, only the Transmittal Letter and IDS with PTO/SB/08 appear to have been entered in the Office's IFW system.

To expedite prosecution of this application, enclosed herewith are the following:

- duplicate copies of the four pages of the prior submission which appear in the Office's IFW system. This includes the Transmittal Letter with Certificate of Fax Transmission signed on 21 January 2005; and
- a duplicate copy of all 16 pages of the prior submission.

Applicant respectfully requests that the enclosed papers be entered into the official file for the above-referenced application. As these papers were timely submitted on 21 January 2005, Applicant respectfully submits that no additional time extension fees are required. However, the Office is hereby authorized to charge any additional fees, including any fees for required time extensions, to Deposit Account 11-1410.

Respectfully submitted,

KNOBBE MARTENS OLSON & BEAR LLP

Dated: 14 apr 05

Ву: _

Kyle F. Schlueter

Registration No. 54,912

Attorney of Record Customer No. 20,995

(310) 551-3450

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PAGE 1/16 * RCVD AT (121/2005 5:26:40 PM [Eastern Standard Time] * SVR:USPTO-EFXRP-1/2 * DNIS:8729306 * CSID: * DURATION (mm-55):04-10

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Docket No.: ASMEX.284DV1

JAN 2 E 2005

Customer No.: 20,995

AMENDMENT / RESPONSE TRANSMITTAL

Applicant

Pomarede, et al.

App. No.

10/626,217

Filed

July 24, 2003

For

SURFACE PREPARATION

PRIOR TO DEPOSITION

Examiner

Christy L. Novacek

Art Unit

2822

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I hereby certify that this correspondence and all marked attachments are being transmitted via facsimile to the USFTO centralized Fax No. (703) 872-9306 on the date shown below:

January 21, 2005

(Date)

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P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Transmitted herewith for filing in the above-identified application are the following enclosures:

- (X) Response to Final Office Action in 3 pages.
- (X) Declaration of Prior Invention in the United States of America to Overcome Cited Patent or Publication with Exhibit A in 9 pages.
- (X) Information Disclosure Statement
- (X) Charge \$180.00 to Deposit Account No. 11-1410 for filing fees for the Information Disclosure Statement.
- (X) Please charge any additional fees, including any fees for additional extension of time, or credit overpayment to Deposit Account No. 11-1410.

Kyle F. Schlueter

Registration No. 54,912

Attorney of Record

Customer No. 20,995

(949) 760-0404

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INFORMATION DISCLOSURE STATEMENT

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App. No

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SURFACE PREPARATION PRIOR TO DEPOSITION

Examiner

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Art Unit

2822

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Dear Sir:

Enclosed for filing in the above-identified application is an Information Disclosure Statement by Applicant (PTO/SB/08 equivalent) listing 2 references to be considered by the Examiner. This Information Disclosure Statement is being filed after the mailing date of a final action or after the mailing date of a Notice of Allowance. This Statement is accompanied by the fee set forth in 37 C.F.R. § 1.17(p). The Commissioner is hereby authorized to charge any additional fees which may be required or to credit any overpayment to Account No. 11-1410.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(2)

I hereby certify that no item of information contained in this Statement was cited in a communication from a foreign Patent Office in a counterpart foreign application, and, to my knowledge after making reasonable inquiry, was known to any individual designated in 37 C.F.R. § 1.56(c) more than 3 months prior to the filing of this information Disclosure Statement.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 21 jan 05

Kyle P. Schlucter, Registration No. 54,912

Attorney of Record Customer No. 20,995

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		P10/SB/08 Equivalent
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INFORMATION DISCLOSURE	Filing Date	July 24, 2003
STATEMENT BY APPLICANT	First Named Inventor	Pomarede, et al.
STATEMENT BY APPLICANT	Art Unit	2822
(Multiple sheets used when necessary)	Examiner	Christy L. Novacek
 SHEET 1 OF 1	Attorney Docket No.	ASMEX.284DV1

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		6,551,399	4/22/03	Sneh, et al.			
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ASMEX.284DV1

Customer No.: 20,995

AMENDMENT / RESPONSE TRANSMITTAL

Applicant

Pomarede, et al.

App. No.

10/626,217

Filed

: July 24, 2003

For

SURFACE PREPARATION

PRIOR TO DEPOSITION

Examiner

: Christy L. Novacek

Art Unit

2822

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January 21, 2005

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Sir:

Transmitted herewith for filing in the above-identified application are the following enclosures:

- (X) Response to Final Office Action in 3 pages.
- (X) Declaration of Prior Invention in the United States of America to Overcome Cited Patent or Publication with Exhibit A in 9 pages.
- (X) Information Disclosure Statement
- (X) Charge \$180.00 to Deposit Account No. 11-1410 for filing fees for the Information Disclosure Statement.
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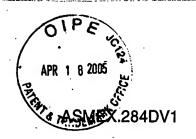
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PATENT

Confirmation Number: 9650

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

Pomarede, et al.

App. No.

10/626,217

Filed

July 24, 2003

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PRIOR TO DEPOSITION

Examiner

Christy L. Novacek

Group Art Unit

2822

Customer No.

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Commissioner for Patents Post Office Box 1450 Alexandria, Virginia 22313-1450

DECLARATION OF PRIOR INVENTION IN THE UNITED STATES OF AMERICA TO OVERCOME CITED PATENT OR PUBLICATION UNDER 37 C.F.R. § 1.131

Sir:

- I, Eric J. Shero, do hereby declare as follows:
- I am a named joint inventor of the subject matter of U.S. Patent Application 10/626,217 (filed 24 July 2003), which is a divisional of U.S. Patent Application 09/944,734 (filed 31 August 2001), which claims the benefit of U.S. Provisional Applications 60/253,693 (filed 24 November 2000) and 60/283,584 (filed 13 April 2001).
- 2. The joint inventors who contributed to the development of the presently claimed invention are Christophe F. Pomarede, Jeff Roberts and Eric J. Shero.
- 3. I have read the Final Office Action dated 17 December 2004, and understand that Claims 1-3, 9-11 and 15 have been rejected by the Examiner under 35 U.S.C. § 102(e) as being anticipated by U.S. Patent 6,800,830 ("Mahawili").

- I further understand that Claims 4–8 and 12–14 stand rejected as being obvious based on Mahawili in view of one or more of U.S. Patent 6,727,148 ("Setton"), U.S. Patent 6,297,539 ("Ma") and U.S. Patent 6,744,104 ("Aoki").
- 5. I conceived of the subject matter of the present application before 18 August 2000 and, therefore, before the earliest priority date to which Mahawili may be entitled.
- 6. Exhibit A is a photocopy of an invention disclosure that describes the invention claimed in the present application. All three joint inventors signed the invention disclosure before 18 August 2000.
- 7. Following conception, I assisted patent attorneys with the preparation of a provisional patent application related to the invention. From a date before 18 August 2000 until filing of a provisional patent application on 24 November 2000, I worked diligently with the patent attorneys to prepare the application and to ensure that it accurately represented the invention.
- 8. All work described herein was performed be me or one of the other joint inventors, or on our behalf, in the Untied States of America.
- 9. All statements made herein of my own knowledge are true. All statements made on information and belief are believed to be true. These statements were made with the knowledge that willful false statements and the like so made are punishable by fine, imprisonment, or both, under 18 U.S.C. § 1001, and that such willful false statements may jeopardize the validity of the application or any patent issuing therefrom.

1/14/05

Date

Hri¢ J. Shero



ASMEX 284A

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mater applied the interest obtained. There informs compared to missing result.	are required to disclose to the rial to the examination of cation must be filed within convention which is the subject of foreign patents, a U.S. pater of the patents of the invention necessary to complete description of the inventional patents of the inventional patents. The patents of the inventional patents in connection with this tant patent. The patents of the inventional patents and employees are not dealers of the inventional patents.	a patent applicance year of the tof the application application mplete the form with these tion in the man information care	ication. In additication. Moreover, must be filed before the befor	on, under U.S ch publicizes of in order to present example to provious alice to provious Also, where the should be noted alice to unenforced to the context of the context	patent law, an recommercializes serve the right to curs. de us with the please attach a nt search may be d that errors and preceability of any
l. Film	Title of Invention: A M Deposition	lethod to Mod	ify the Surface Te	rmination of Lo	yers Prior to
2.	Inventor(s): Full Name ¹ (including middle initial) Eric J. Shero	<u>Citizenship</u> U.S	City, State & Cot of Residence ASM America, 1	Postal Inc. 3440 I	Address East University Dr ix, AZ 85034-7200
	Christophe F. Pomerade	France	ASM America,	3440 I	East University Dr

ASM America, Inc.

Jeff Roberts

U.S

ASM America, Inc. 3440 East University Dr Phoenix, AZ 85034-7200

Include all persons associated with the making of the invention. Please note that only true inventors, as determined under the technical requirements of the patent law, can be named in a patent application, and that no such inventor should be omitted.

3. Conception of the Invention:

Place(s)

Inventive Circumstances²

ASMA Harbour Bldg.

All were discussing poor interface between Silicon and ALCVD zirconia. ES suggested using F or Cl radicals generated by RP source to produce surface moieties that are easily attacked by water to form silanol groups. CP and JR suggested similar measures at high K-poly interface making Si-N or Si-Si surface bonds to promote B diffusion suppression and enhance poly-Si or SiGe nucleation.

²Briefly describe the contributions, suggestions, experiments, etc. of each inventor listed above, as well as any other pertinent circumstances surrounding the conception of the invention.

4. Initial drawings or sketches and written description of the invention:

Place(s)

Circumstances 3

ASMA - University

Excel spreadsheet(s) describing development timeline using RP (remote plasma) generated radicals for surface modification prior to several thin film depositions

³Attach copies, if available, or describe the present location of initial drawings, sketches, lab notebooks, description, etc.

5. Initial disclosure of the invention to others:

Place(s)

Person(s) receiving disclosure

ASMA - University

E. Strickland, R. Bergman, M. Jackson, Jim Gutt, Timo Bergman, Chris Werkhoven



Circumstances

Presented Sematech with high K development plan on Phoenix cluster/Pulsar that included using different surface terminations before zirconia ALCVD

6. Initial tests, uses or operations of the invention:

Place(s)

Person(s) present

Circumstances4

⁴Describe any changes made as a result of these initial tests, uses or operations.

7. What is the closest "prior art"; that is, what devices, technologies, structures, processes, information or materials which existed publicly or privately before the invention was made are considered to be most closely related to the invention? Each person identified in Paragraph 2 should answer this question.

Date(s)

Place(s)

Person(s) involved

Circumstances⁵

Most closely related are CVD film deposition patents that utilize remote plasma sources to generate radicals to vapor deposit continuous films, i.e greater than one monolayer of material.

No one has specifically (as far as I have seen in a 2 hour search of USPTO database) addressed the utility of using RP excited gases to modify the surface termination of the base layer prior to the deposition of a thin layer of a different material. Especially with respect to an adsorption driven processes such ALD (and MOCVD, CVD and JVD for that matter) or a nucleation sensitive process like poly-Si and SiGe (SiGeC) deposition on dielectric materials.

⁵Identify and, if possible, attach copies of prior publications, patents, etc. which are most closely related to the invention.

8. Other than the initial disclosure described in paragraph 5, has the invention ever been disclosed orally or in writing to any person other than the fellow employees? If so, provide the following information:

Place(s)

Person(s) receiving disclosure

Espoo, Finland

Suvvi Hauka

Circumstances⁶

ES was asking the question to Dr. Hauka if she believed a F terminated Si surface would be more susceptable to attack by moisture to form the silanol groups that metal chlorides need to chemisorb.

⁶Include any instances of private or public offers to sell the invention, as well as requests for financing, grant applications, demonstrations, theses, abstracts, oral presentations, trade shows, catalogs, etc. Identify all relevant publications, correspondence, etc. and, if possible, attach copies.

9. Has the invention ever been used commercially for any purpose? If so, provide the following information

Date(s)

Place(s)

Person(s) involved

Circumstances7

Not to my knowledge

⁷Include any commercial uses, even if details of the invention were kept secret and not disclosed to the public.

10. Are any disclosures planned for the near future?

<u>Planned Disclosure</u> 8

Approximate Date

Circumstances!

Depending on results obtained at ASMA, and if they are shared with Sematech, may be presented by Sematech at first opportunity to member companies.

⁸Describe any imminent publication, oral presentation, trade show, offer of sale, or sale of the invention.

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11. Identify any identities that sponsored or paid, in whole or in part, for the work that led to the conception or reduction to practice of the invention.

Entity

Nature of Sponsorship

Circumstances9

None, conceived before any work had begun with Sematech and they had no involvement on conception

⁹Describe the contribution of any funds, grants, salaries, materials, equipment or facilities provided by any governmental agency, academic or research institution, industrial sponsor, etc.

12. Invention Disclosure:

Describe the invention in the spaces provided below. If necessary to fully describe the invention, attach reports, drawings, written descriptions, shop and lab notebook records, etc. Please note that the patent application based on this invention must be sufficiently detailed so as to "enable" a person of ordinary skill in this technology to make and use the invention, and that is must disclose the "best mode" for carrying out the invention.

(1) <u>BACKGROUND</u>. Describe the field to which the invention relates and explain what is wrong with the prior art. Provide sufficient background information to enable the reader to clearly appreciate the problems that existed prior to the invention.

The current state of the art in remote, radical assisted processes have targeted the CVD of continuous films, i.e. greater than one monolayer of material. No one has specifically (as far as I have seen with a very limited search) addressed the utility of using RP excited gases to change the surface termination prior to an adsorption driven and sensitive processes such ALD or nucleation sensitive process like poly on high K.

What is needed is a low temperature method to simply change the surface termination between thin layers, without *depositing* a film of significant thickness or *modifying its bulk composition*. Either of these paths could adversely effect the behavior of the stacked structure.

By changing the surface termination, one can "kick-start" the chemisorption process of certain precursors on materials (such as, but not limited to) silicon. This will

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accelerate the ALD process or make it entirely possible. This is similar to what people have done using wet chemistries, i.e. changing the surface termination of a wafer from -O to -H, so that silicon can be epitaxially grown. A remote plasma is simply another mechanism to accomplish a change in surface termination.

The novelty and invention is to use a remote plasma source (or an in-situ plasma), in a cluster tool environment, to allow the grafting of atoms or groups onto a surface that normally may require high temperature in order to achieve the necessary energy to break the existing surface bonds. The process should be clustered to avoid desorbing or contaminating the surface species before the next process step which is surface sensitive like ALCVD or CVD. The process will be tuned such that the remote plasma source imparts the necessary activation energy to break the surface bonds and form new ones, while the temperature is maintained low enough to prevent etching of the substrate or significant diffusion of the active species into the "bulk".

(2) <u>DESCRIPTION.</u> Write a detailed description of the invention, referencing sketches, drawings or photographs. Describe the best way to carry out the invention

Utilize Remote Plasma (RP) or in-situ plasma sources to excite gases which react with the surface atoms of a film to *change its surface termination* before deposition of the next thin film in a multi-layered stack structure. Relevant sample structures include CMOS gate stacks, DRAM capacitors, and floating gate transistors to name a few.

Modification of the surface terminating groups with radical moieties prior to next layer deposition has direct application in permitting, promoting or accelerating the chemisorption of atomic layer deposition (ALD), MOCVD and CVD precursors. Furthermore, changing the surface termination between layers can promote layer adhesion or nucleation specifically in the area of poly or metal gates on high K materials. By making an interface more like the material of the next film, unfavorable surface free energy changes can be overcome.

- (3) <u>ADVANTAGES</u>. List and explain the advantages of the invention in the order of their importance, and describe how the invention solves or overcomes the problems of the prior art. Include all possible uses and modifications of the invention. Speculate reasonably on any additional uses that the invention may have, either by itself or in combination with other known or as yet unknown technologies.
 - Accelerates or promotes chemisorption of ALD, MOCVD, or CVD precursors onto substrates by increasing or changing surface reactivity. Currently,



practitioners of these deposition schemes do not attempt to singly modify the surface termination prior to the initial reactant exposure of the wafer, using plasma processes. The advantage of plasma processes is specific engineering of the surface termination through precursor selection, plasma power and frequency, and temperature.

- 2. Changing the surface termination via remote plasma or in-situ plasma processing can insert a single monolayer of atoms at the surface of a layer to act as an adhesion promoter or diffusion barrier without affecting the bulk properties of the thin films.
- 3. A low temperature method that is compatible with the current temperature range utilized in ALD reactors, thus allowing integration into existing reactor designs.
- 13. I (we) verify that the foregoing is true and correct.

<u>Signature¹⁰</u>

Inventor(s):

Printed name

Eric Shero

Christophi Ponnece

JAF Robert

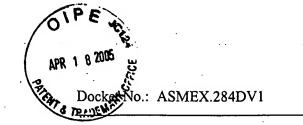
Witnessed and Understood (two or more witnesses should sign):

Signature¹⁰___

Printed name

ROBERT PALLARD

¹⁰All inventors and witnesses should initial and date each page of the attachments.



INFORMATION DISCLOSURE STATEMENT

Applicant

Pomarede, et al.

App. No

10/626,217

Filed

July 24, 2003

For

SURFACE PREPARATION PRIOR TO DEPOSITION

Examiner

Christy L. Novacek

Art Unit

2822

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is an Information Disclosure Statement by Applicant (PTO/SB/08 equivalent) listing 2 references to be considered by the Examiner. This Information Disclosure Statement is being filed after the mailing date of a final action or after the mailing date of a Notice of Allowance. This Statement is accompanied by the fee set forth in 37 C.F.R. § 1.17(p). The Commissioner is hereby authorized to charge any additional fees which may be required or to credit any overpayment to Account No. 11-1410.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(2)

I hereby certify that no item of information contained in this Statement was cited in a communication from a foreign Patent Office in a counterpart foreign application, and, to my knowledge after making reasonable inquiry, was known to any individual designated in 37 C.F.R. § 1.56(c) more than 3 months prior to the filing of this Information Disclosure Statement.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 21 jan 05

Kyle P. Schlueter, Registration No. 54,912

Attorney of Record Customer No. 20,995 (949) 760-0404

OTP 6 10 2005		PTO/SB/08 Equivaler
E 5	Application No.	ASMEX.284DV1
INFORMATION DISCLOSURE	Filing Date	July 24, 2003
INFORMATION DISCLOSURE	First Named Inventor	Pomarede, et al.
STATEMENT BY APPLICANT	Art Unit	2822
(Multiple sheets used when necessary)	Examiner	Christy L. Novacek
SHEET 1 OF 1	Attorney Docket No.	ASMEX.284DV1

U.S. PATENT DOCUMENTS							
Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear			
	6,503,330	1/7/03	Sneh, et al.				
	6,551,399	4/22/03	Sneh, et al.				
		No. Number - Kind Code (if known) Example: 1,234,567 B1 6,503,330	Cite No. Document Number Number - Kind Code (if known) Example: 1,234,567 B1 Publication Date MM-DD-YYYY 6,503,330 1/7/03	Cite No. Document Number Publication Date Number - Kind Code (if known) Example: 1,234,567 B1 Publication Date MM-DD-YYYY Name of Patentee or Applicant 6,503,330 1/7/03 Sneh, et al.			

	FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹	
1. 20							

	NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹		

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Date Considered **Examiner Signature**

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place à check mark in this area when an English language Translation is attached.

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